

<b>Notice of References Cited</b>	Application/Control No. 10/085,684	Applicant(s)/Patent Under Reexamination SHEN ET AL.	
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*	B	US-6,671,322	12-2003	Vetro et al.	375/240.16
*	C	US-2003/0021345 1/2003	<del>03-2004</del>	Brusewitz	375/240.18
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